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TRITEC	DRMATION	ושומו		Application Number	10/705.946			
				Filing Date	November 13, 2003			
stai	EMENT BY	API	PLICANT	First Named Inventor	Craig C. HANSEN, et al.			
				Group Art Unit	2183			
(use as many sheets as necessary)				Examiner Name	CHAN, EDDIE P			
Sheet	1	of	10	Attorney Docket Number	43876-147			

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Examiner Signature Cut Date Considered 3/3/06

*EXAMINER: Initial reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered, include copy of this form with next communication to applicant. I Applicant's unique citation designation number (optional). 2 See Kinds Codes of USPTO Patent Documents as www.uspio.soy or MPEP 901.04. 3 Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). 4 For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. 5 kind of document by the appropriate symbols as indicated on the document under WIPO Standard St.16 if possible. 6 Applicant is to place a check mark here if English language translation is attached. The collection of information is required by 37 CFR 1.97 and 1.98. The information is required to obtain or retain a benefit by the public which is to file (and by the USPTO to process) an application. Confidentiality is governed by 35 U.S.C. 122 and 37 CFR 1.14. This collection is estimated to take 2 hours to complete including gathering, preparing, and submitting the completed application form to the USPTO. Time will vary depending upon the individual case. Any comments on the amount of time you require to complete this form and/or suggestions for reducing this burden, should be sent to the Chief Information Officer, U.S. Patent and Trademark Office, U.S. Department of Commerce, P. O. Box 1450, Alexandria, VA 22313-1450. If you need assistance in completing the form, call 1-800-PTO-9199 and select option 2

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